

IN THE CLAIMS

Please amend claim 35 as follows:

1-34. (Cancelled)

35. (Currently Amended) An evaluation circuit for detecting and/or locating faulty data words in a data stream T_n comprising:

a first linear automaton circuit and a second linear automaton circuit connected in parallel, each having a set of states, wherein the first linear automaton circuit and the second linear automaton circuit each have inputs that are commonly connected for receiving a data stream T_n comprising n successive data words $y(1), \dots, y(n)$ each having a width of k bits, $k > 1$, wherein the first linear automaton circuit can be described by the following equation

$$z(t+1) = Az(t) \oplus y(t)$$

wherein the second linear automaton circuit can be described by the following equation

$$z(t+1) = Bz(t) \oplus y(t)$$

where z represents state vectors and A and B represent the state matrices of the linear automaton circuits, where the state matrices A and B can be inverted, and where a dimension L of the state vectors z is $\geq k$, wherein $A \neq B$.

the first linear automaton circuit and the second linear automaton circuit are designed such that a first signature and a second signature, respectively, can be calculated of each data word,

L first logic combination gates arranged downstream of the first linear automaton circuit and also L second logic combination gates arranged downstream of the second linear automaton circuit,

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the logic combination gates are designed such that the signature respectively calculated by the linear automaton circuit can be compared with a predeterminable good signature and a comparison value can be output.

36. (Previously Presented) The evaluation circuit as claimed in claim 35, comprising wherein the logic combination gates are present as exclusive-OR gates whose first inputs are respectively connected to the outputs of the associated linear automaton circuit (L1, L2) and to whose second inputs good signatures can be applied.

37. (Previously Presented) The evaluation circuit as claimed in claim 35, comprising wherein arranged upstream of the first linear automaton circuit is a first coder, that encodes the data word $y(i)$ having the data word length of k bits into an encoded data word $u^1(i)$, $u^1(i) = \text{Cod1}$ having the word width of $K1$ bits, for $i=1, \dots, n$, and where Cod1 represents the encoding function of the first coder.

38. (Previously Presented) The evaluation circuit as claimed in claim 37, comprising wherein the following holds true for the encoding function of the first coder:

$$\text{Cod1}(y'(i)) = u^1(i) \oplus f_1(e(i)),$$

or

$$\text{Cod1}(y'(i)) = \text{Cod1}(y(i) \oplus e(i)) = \text{Cod1}(y(i) \oplus f_1(e(i)))$$

where a function f_1 by $f_1(0) = 0$ exists for $y'(i) = y(i) \oplus e(i)$, and where a function f_1^{-1} where

$$f_1^{-1}(f_1(e)) = e$$

exists for all binary data words e having the word width k which may occur as errors of a data word, where e denotes a faulty data word of the data stream T_n .

39. (Previously Presented) The evaluation circuit as claimed in claim 37, comprising wherein arranged upstream of the second linear automaton circuit is a second coder, which encodes the data word $y(i)$ having the data word length of k bits into an encoded data word $u^2(i)$,

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$u^2(i) = \text{Cod2}(y(i))$ having the word width of K_2 bits, for $i=1, \dots, n$, and where Cod2 represents the encoding function of the second coder.

40. (Previously Presented) The evaluation circuit as claimed in claim 39, comprising wherein the following holds true for the encoding function of the second coder:

$$\text{Cod2}(y'(i)) = u^2(i) \oplus f_2(e(i)),$$

or

$$\begin{aligned} \text{Cod2}(y'(i)) &= \text{Cod2}(y(i) \oplus e(i)) \\ &= \text{Cod2}(y(i)) \oplus f_2(e(i)) \end{aligned}$$

where a function f_2^{-1} where

$$f_2^{-1}(f_2(e)) = e$$

exists for all binary data words e having the word width k which may occur as errors of a data word, where e denotes a faulty data word of the data stream T_n .

41. (Previously Presented) The evaluation circuit as claimed in claim 39, comprising wherein that the word width K_1 of the data words $u^1(i)$ encoded by the first coder is equal to the word width K_2 of the data words $u^2(i)$ encoded by the second coder.

42. (Previously Presented) The evaluation circuit as claimed in claim 39, comprising wherein the first coder matches the second coder with regard to its construction and its function.

43. (Previously Presented) The evaluation circuit as claimed in claim 39, comprising wherein the word width K_1 of the data words $u^1(i)$ encoded by the first coder and the word width K_2 of the data words $u^2(i)$ encoded by the second coder are in each case equal to the word width k of the data words $y(1), \dots, y(n)$ of the data stream T_n .

44. (Previously Presented) The evaluation circuit as claimed in claim 39, comprising wherein the encoding functions Cod1 and Cod2 of the first coder and of the second coder are designed as follows:

$$\begin{aligned} &\text{Cod1}(y_1(i), y_2(i), \dots, y_k(i)) \\ &= P1(y_1(i), y_2(i), \dots, y_k(i), 0, \dots, 0) \end{aligned}$$

$$\begin{aligned} &\text{Cod2}(y_1(i), y_2(i), \dots, y_k(i)) \\ &= P2(y_1(i), y_2(i), \dots, y_k(i), 0, \dots, 0) \end{aligned}$$

for $i, 1, \dots, n$

where the number of zeros situated at the end of $P1(y_1(i), y_2(i), \dots, y_k(i), 0, \dots, 0)$ is equal to $(K1-k)$, where the number at the end of $P2(y_1(i), y_2(i), \dots, y_k(i), 0, \dots, 0)$ is equal to $(K2-k)$, and where P1 represents an arbitrary permutation of the $K1$ components of $(y_1(i), y_2(i), \dots, y_k(i), 0, \dots, 0)$ and P2 represents an arbitrary permutation of the $K2$ components of $(y_1(i), y_2(i), \dots, y_k(i), 0, \dots, 0)$.

45. (Previously Presented) The evaluation circuit as claimed in claim 37, comprising wherein the coding functions Cod1 and Cod2 of the first coder and of the second coder are designed as follows:

$$\begin{aligned} &\text{Cod1}(y_1(i), y_2(i), \dots, y_k(i)) \\ &= P1(y_1(i), y_2(i), \dots, y_k(i), b_1^1, \dots, b_{K1-k}^1) \end{aligned}$$

$$\begin{aligned} &\text{Cod2}(y_1(i), y_2(i), \dots, y_k(i)) \\ &= P2(y_1(i), y_2(i), \dots, y_k(i), b_1^2, \dots, b_{K2-k}^2) \end{aligned}$$

where $b_1^1, \dots, b_{K1-k}^1, b_1^2, \dots, b_{K2-k}^2 \in \{0.1\}$, and where P1 and P2 represent arbitrary permutations.

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46. (Previously Presented) The evaluation circuit as claimed in claim 37, comprising wherein the encoding function Cod1 of the first coder is designed such that it realizes a linear block code, $f_1 = \text{Cod1}$.

47. (Previously Presented) The evaluation circuit as claimed in claim 39, comprising wherein the encoding function Cod2 of the second coder is designed such that it realizes a linear block code, $f_2 = \text{Cod2}$.

48. (Previously Presented) The evaluation circuit as claimed in claim 35, comprising wherein the state matrix A of the first linear automaton circuit and the state matrix B of the second linear automaton circuit are related to one another as follows:

$$B = A^n$$

where $n \neq 1$.

49. (Previously Presented) The evaluation circuit as claimed in claim 35, comprising wherein the state matrix B of the second linear automaton circuit is equal to the inverted state matrix A^{-1} of the first linear automaton circuit.

50. (Previously Presented) The evaluation circuit as claimed in claim 35, comprising wherein the first linear automaton circuit is designed as a linear feedback shift register and the second linear automaton circuit is designed as an inverse linear feedback shift register, both linear automaton circuits having a parallel input.

51. (Previously Presented) The evaluation circuit as claimed in claim 35, comprising wherein the first linear automaton circuit is designed as a linear feedback, multi-input shift register or the second linear automaton circuit is designed as a linear feedback, multi-input shift register.

52. (Previously Presented) The evaluation circuit as claimed in claim 51, comprising wherein the multi-input shift registers have a primitive feedback polynomial of maximum length.

53. (Previously Presented) A method for testing an integrated circuit device by detecting and/or locating faulty data words in a data stream T_n , the method having the following method steps of:

inputting data words $y(1), \dots, y(i-1), y'(i), y(i+1), \dots, y(n)$ of a data stream T_n into a first coder, each data word having a width of k bits, $k > 1$,

encoding the data words $y(1), \dots, y(n)$ into encoded data words $u^1(1), \dots, u^1(n)$ having a word width $K1$ where $K1 \geq k$ by means of the coding function $Cod1$ of a first coder,

inputting the coded data words $u^1(1), \dots, u^1(i-1), u^{1'}(i)$ or $u^1(i), u^1(i), \dots, u^1(n)$ into the inputs of a first linear automaton circuit, which is described by the automaton equation;

$$z^1(t+1) = A \cdot z^1(t) + u^1(t)$$

where t is an instant in time, z^1 represents a $K1$ -dimensional state vector and A represents a $K1 \times K1$ state matrix, and where the state matrix A can be inverted,

processing the coded data words $u^1(1), \dots, u^1(i-1), u^{1'}(i)$ or $u^1(i), u^1(i), \dots, u^1(n)$ by means of the first linear automaton circuit, the first linear automaton circuit,

undergoing transition to the state $z^1(n+1) = S_1(L1, y(1), \dots, y(i-1), y(i), y(i+1), \dots, y(n))$ if no error can be detected in the case of the coded data words $u^1(1), \dots, u^1(i-1), u^1(i), u^1(i+1), \dots, u^1(n)$,

undergoing transition to the state $z^{1'}(n+1) = S_1(L1, y(1), \dots, y(i-1), y'(i), y(i+1), \dots, y(n))$ if an error is present at least in the case of the i -th position of the coded data words $u^1(1), \dots, u^1(i-1), u^{1'}(i), \dots, u^1(n)$,

the signature of an error-free data stream T_n being designated by $S(L1, y(1), \dots, y(i-1), y(i), y(i+1), \dots, y(n))$ and the signature of a faulty data stream T_n being designated by $S(L1, y(1), \dots, y(i-1), y'(i), y(i+1), \dots, y(n))$,

checking the determined signature of the data stream T_n and continuing with method step a) for further data streams T_n if the determined signature of the data stream T_n is the signature of an error-free data stream T_n ,

inputting the data words $y(1), \dots, y(i-1), y'(i), \dots, y(n)$ of the data stream T_n in a second coder,

coding the data words $y(1), \dots, y(i-1), y'(i), y(i+1), \dots, y(n)$ to coded data words $u^2(1), \dots, u^2(i-1), u^{2'}(i)$ or $u^2(i), u^2(i), \dots, u^2(n)$ having the word width $K2$ where $K2 \geq k$ by means of the coding function $Cod2$ of the second coder,

inputting the coded data words $u^2(1), \dots, u^2(i-1), u^{2'}(i)$ or $u^2(i), u^2(i), \dots, u^2(n)$ into the inputs of a second linear automaton circuit, which is described by the automaton equation

$$z^2(t+1) = B \cdot z^2(t) \oplus u^2(t)$$

where z^2 represents a $K2$ -dimensional state vector and B represents a $K2 \times K2$ state matrix where $B \neq A$, and where the state matrix B can be inverted,

processing the coded data words $u^2(1), \dots, u^2(i-1), u^{2'}(i)$ or $u^2(i), u^2(i), \dots, u^2(n)$ by means of the second linear automaton circuit, the second linear automaton circuit,

undergoing transition to the state $z^2(n+1) = S_2(L2, y(1), \dots, y(i-1), y(i), y(i+1), \dots, y(n))$ if no error can be detected in the case of the data words $u^2(1), \dots, u^2(i-1), u^2(i), \dots, u^2(n)$,

undergoing transition to the state $z^{2'}(n+1) = S_2(L2, y(1), \dots, y(i-1), y(i), y'(i), y(i+1), \dots, y(n))$ if an error is present at least in the case of the i -th position of the coded data words $u^2(1), \dots, u^2(i-1), u^{2'}(i), u^2(i), \dots, u^2(n)$,

the signature of an error-free data stream T_n being designated by $S(L2, y(1), \dots, y(i-1), y(i), y(i+1), \dots, y(n))$ and the signature of a faulty data stream T_n being designated by $S(L2, y(1), \dots, y(i-1), y'(i), \dots, y(n))$,

determining the signature differences $\Delta S1$ and $\Delta S2$ by means of exclusive-OR logic combinations of the signatures $S1$ and $S2$ with ascertained good signatures, in each case according to the following specifications:

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$$\Delta S1 = S(L1, y(1), \dots, y(i-1), y(i), y(i+1), \dots, y(n))$$

$$\oplus S(L1, y(1), \dots, y(i-1), y'(i), y(i+1), \dots, y(n))$$

$$\Delta S2 = S(L2, y(1), \dots, y(i-1), y(i), y(i+1), \dots, y(n))$$

$$\oplus S(L2, y(1), \dots, y(i-1), y'(i), y(i+1), \dots, y(n))$$

determining a unique solution for the position i of the faulty bit in the faulty data word by solving the equation

$$f_1^{-1}(A^{i-n} \Delta S1) = f_2^{-1}(B^{i-n} \Delta S2)$$

and if no unique solution results for $1 \leq i \leq n$, outputting a notification by means of an output medium that two or more errors are present in the data stream T_n under consideration,

determining a unique solution for the counter $e(i)$ of the faulty data word $y'(i)$ in the data stream T_n by solving the equation

$$e(i) = f_1^{-1}(A^{i-n} \cdot \Delta S1)$$

outputting the position i of the faulty bit in the faulty data word and also the error $e(i)$ of the faulty data word $y'(i)$ in the data stream T_n by means of an output medium; and

evaluating an integrated circuit in response to the output.

54. (Cancelled)

55. (Previously Presented) The evaluation circuit as claimed in claim 35, comprising wherein the evaluation circuit is monolithically integrated on an integrated circuit, each data word having a data word length of k .

56. (Previously Presented) A loadboard for receiving at least one needle card for testing integrated circuits or having at least one test socket for testing integrated circuits or for connecting a handler to a tester of integrated circuits, the loadboard having an evaluation circuit as claimed in claim 35.

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57. (Previously Presented) A needle card for testing integrated circuits, in which an evaluation circuit as claimed in claim 35 is integrated.

58. (Previously Presented) A tester for testing integrated circuits having the following features:

the tester is provided with a plurality of instruments for generating signals or data streams and with a plurality of measuring sensors, in particular for currents and voltages,

the tester has a loadboard which is provided for receiving at least one needle card for testing integrated circuits and/or for connecting a handler to a tester of integrated circuits and/or which is equipped with at least one test socket for testing integrated circuits, and

the tester has an evaluation circuit as claimed in claim 35.

59-60. (Cancelled)

61-63 (Cancelled)